

Enhancing Signal Accuracy and Bandwidth Extension in Transient Shock Measurements Using Transfer Function Compensation

Transfer Function Techniques for Improving Data Quality and Results Standardization

Strether Smith
Strether Smith Consulting
Strether.smith@comcast.net / (408) 202 6821
<https://blog.endaq.com/author/strether-smith>

Ted Diehl, PhD
CEO & President, Bodie Technology, Inc.
Ted.Diehl@BodieTech.com / 610-368-3638
www.BodieTech.com

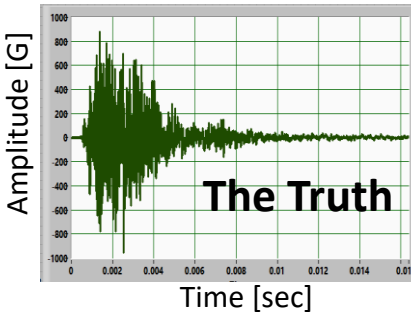
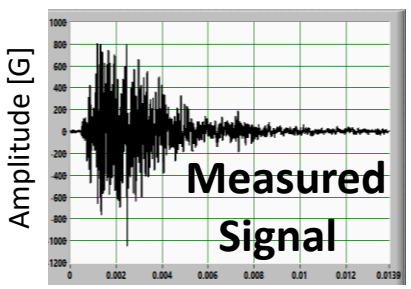
Objectives

- Provide a Method for Removing the Distortions Introduced by the Non-Idealities of the Measurement Components.
- Increase the Frequency Range of the Measurement to Beyond Their Nominal Bandwidth.
- Demonstrate a “Normalization” Feature that Allows Results from Different Laboratories/Experiments to Be Directly Compared.

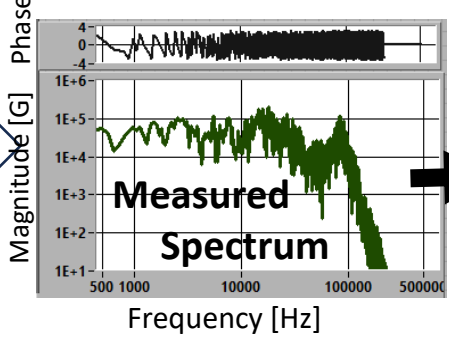
Background

Combines the Work of

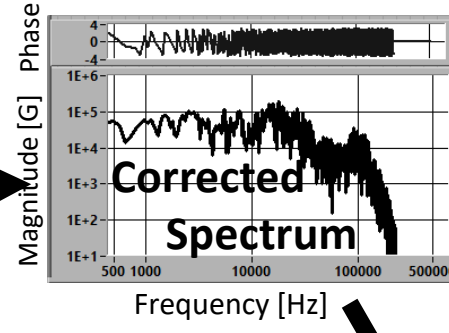
- Walter
 - PFI
 - Smith
-Into One Integrated Digital Process.



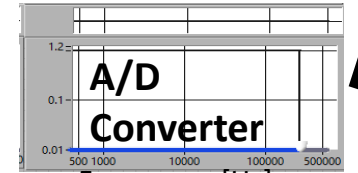
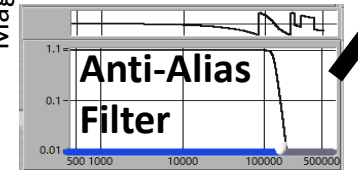
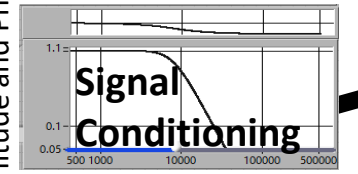
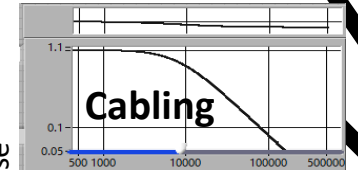
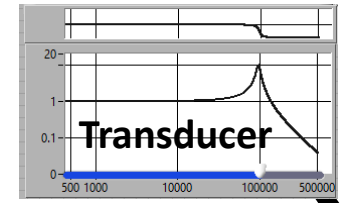
FT



X



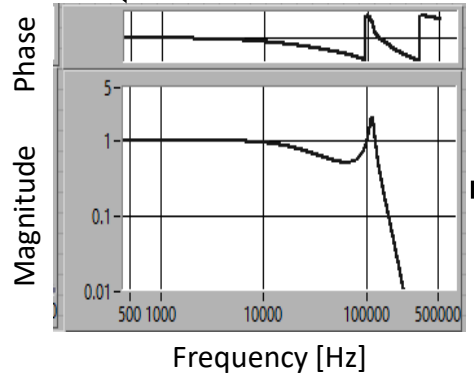
Our Goal is to Understand This Chart



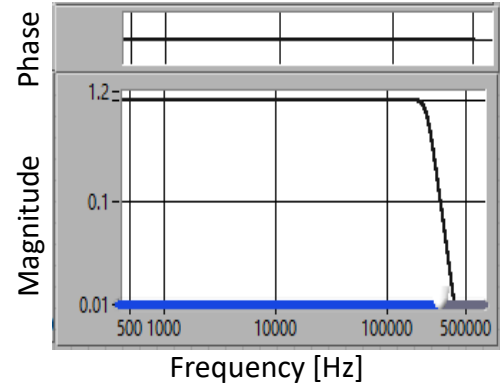
Various Transfer Functions

X

System Transfer Function

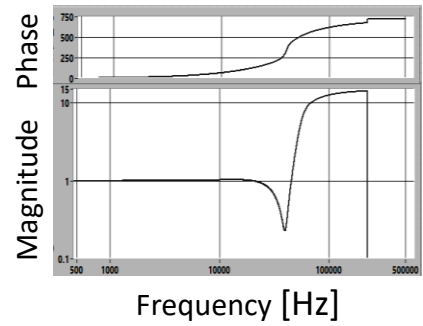


Desired Transfer Function

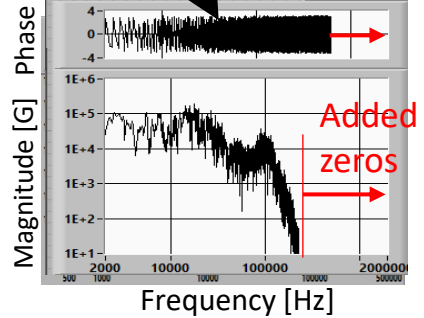


/

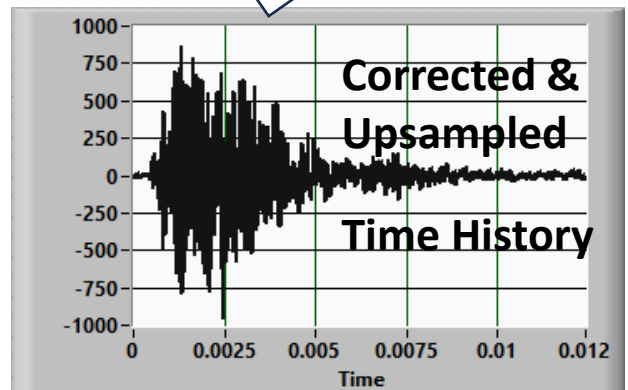
Correction Transfer Function



UpSample via adding zeros at end of spectrum



FT⁻¹



**It Would Be Great If
All Test Labs Doing Similar Experiments
Used The Same
Transducers,
Cabling Systems,
Signal Conditioners,
Alias-Protection Devices and
Analog-to Digital Converters
and Data Acquisition Strategies
*But They Don't***

So

Different Laboratories

Performing The

Same Experiment

Will Produce

Different Results

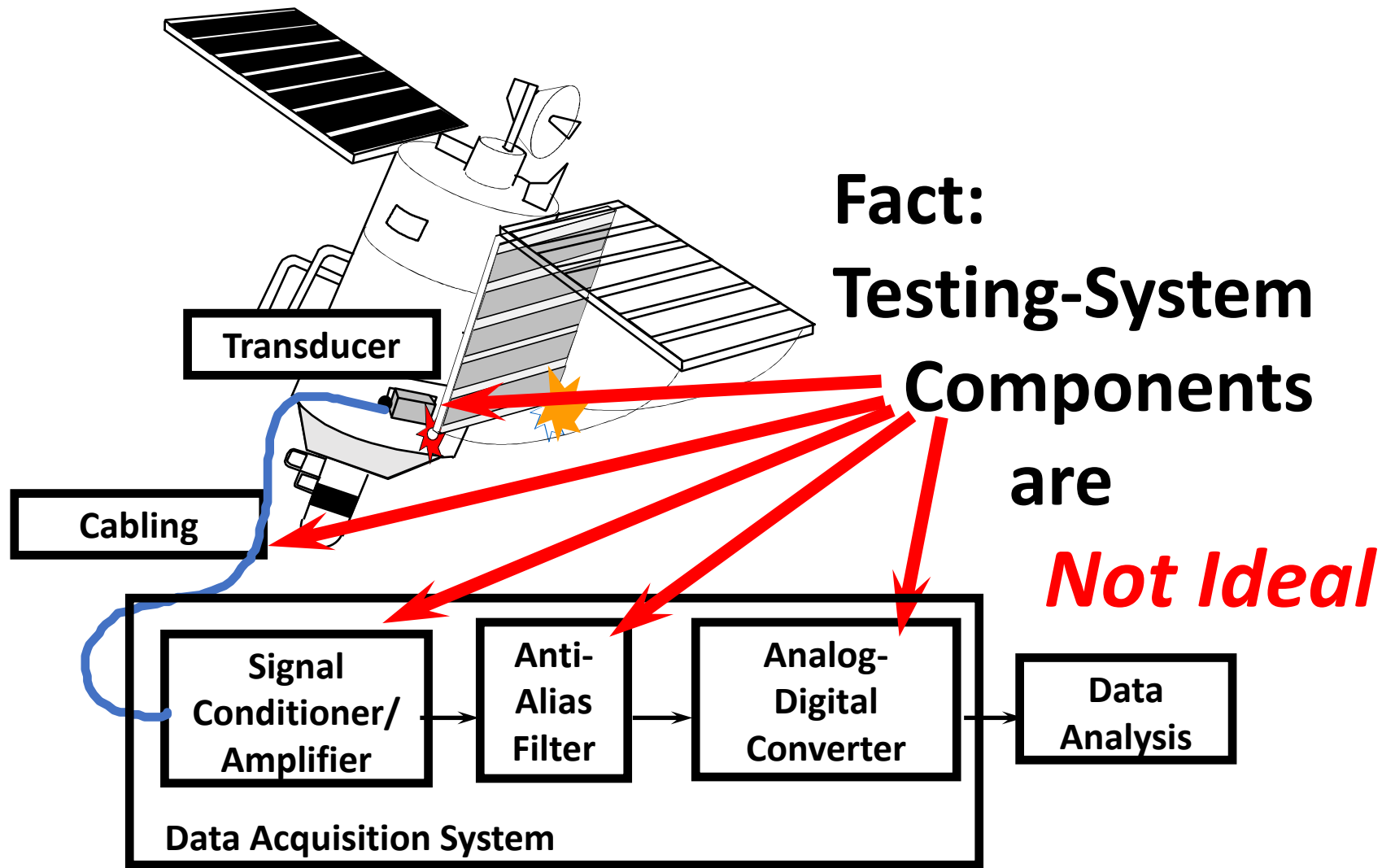
AND *(For Additional DSP-Related Reasons)*

Comparing Transient FEA To Physical Tests

Will Often Yield ***Different Results***

Why:

- Different Hardware Components
In The Signal Chain
Will Distort The Signal
In Different Ways
- Different Measurement Bandwidth
Will Produce Different Results



Fact: A Real Measurement System
Will Always Produce
A Distorted
Version of the Truth

Our Objective:

Produce Improved Results With
Consistent Distortion (we cannot remove it all)
Between Tests/Laboratories (or Models and Tests)

Then, Results May Be Consistently Compared

Fact:
Transient FEA Models Also
Produce A Distorted
Version Of The Truth:
Physics + Solution noise +
Modeling Approximations

History

In 1981 Walter Proposed Using
Convolution Functions to Correct For The Distortion

In 1991 Smith & Hollowell Proposed Limiting
The Frequency Response of Shock Events
With a Standard Low-Pass Filter.

In 2022 Gerber, Firth, & Szary
Offered an Analog Approach For The Compensation Of
Transducer Resonance Effects

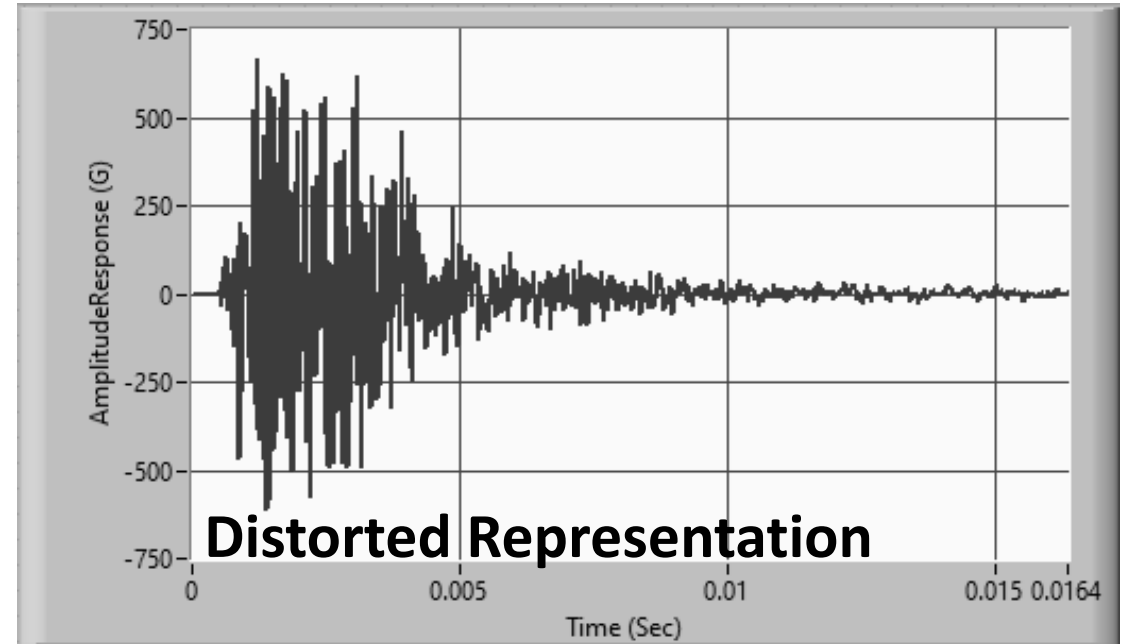
In This Presentation, the Concepts are
**Combined In A Digital Process to Produce a
Consistently Distorted, Standardized, Result**

Fact: Our Measurement Systems Do Not Tell Us The Truth



Truth

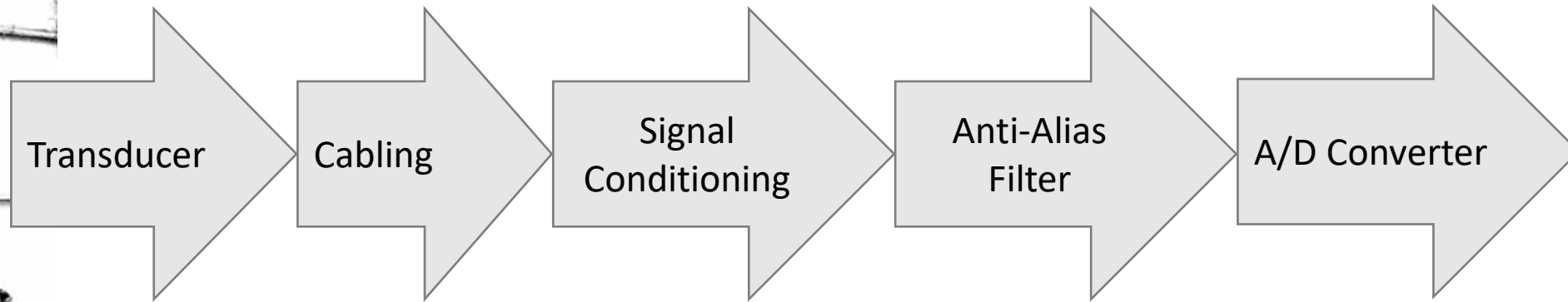
Measurement System



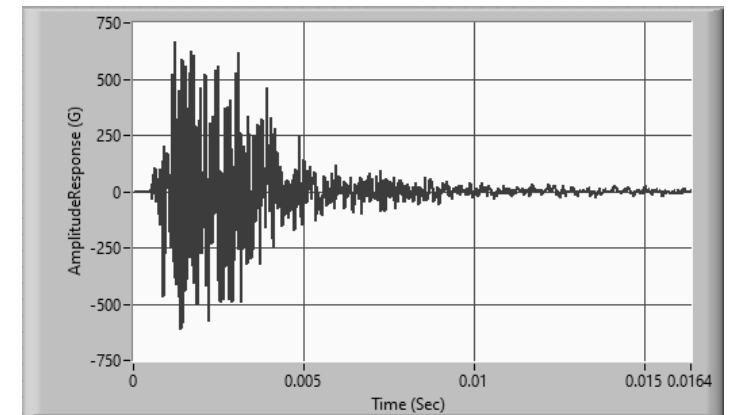
A Little History

Lockheed Sunnyvale's Hubble Space Telescope Demonstrator
(Lots of Firsts Accomplished With This Hardware and Test)

More Detail



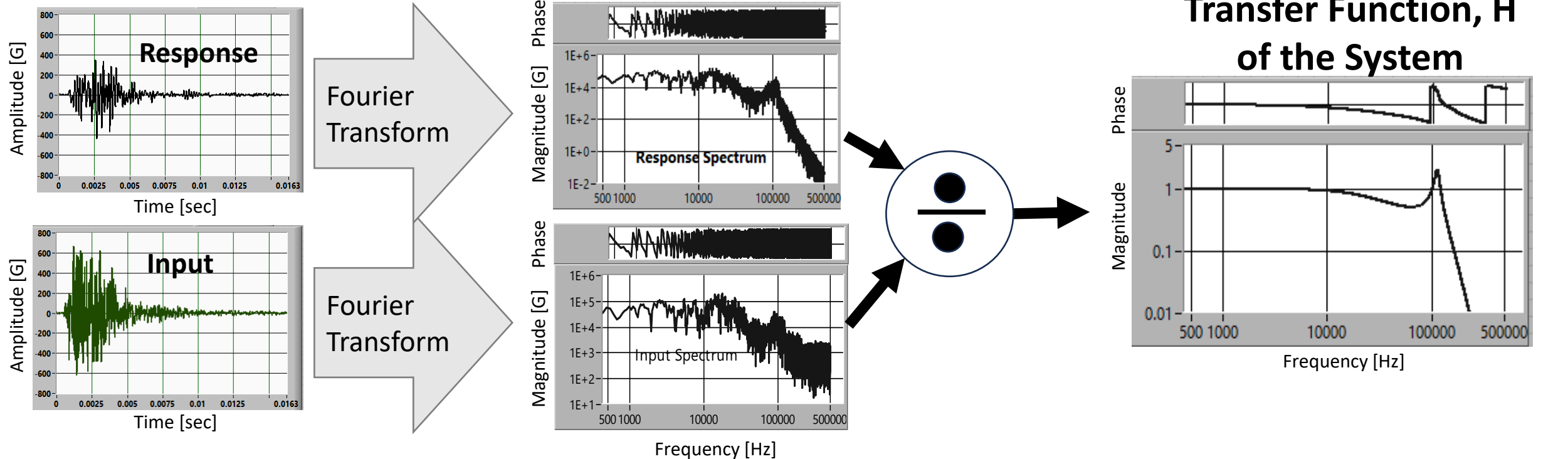
**All Of The
Components Contribute
*Distortion***



A Few Signal Analysis Basics

For a Linear System, the Magnitude and Phase (delay) difference between Input and Response Signals can be Characterized With a Transfer Function.

The Basic Calculation Is:

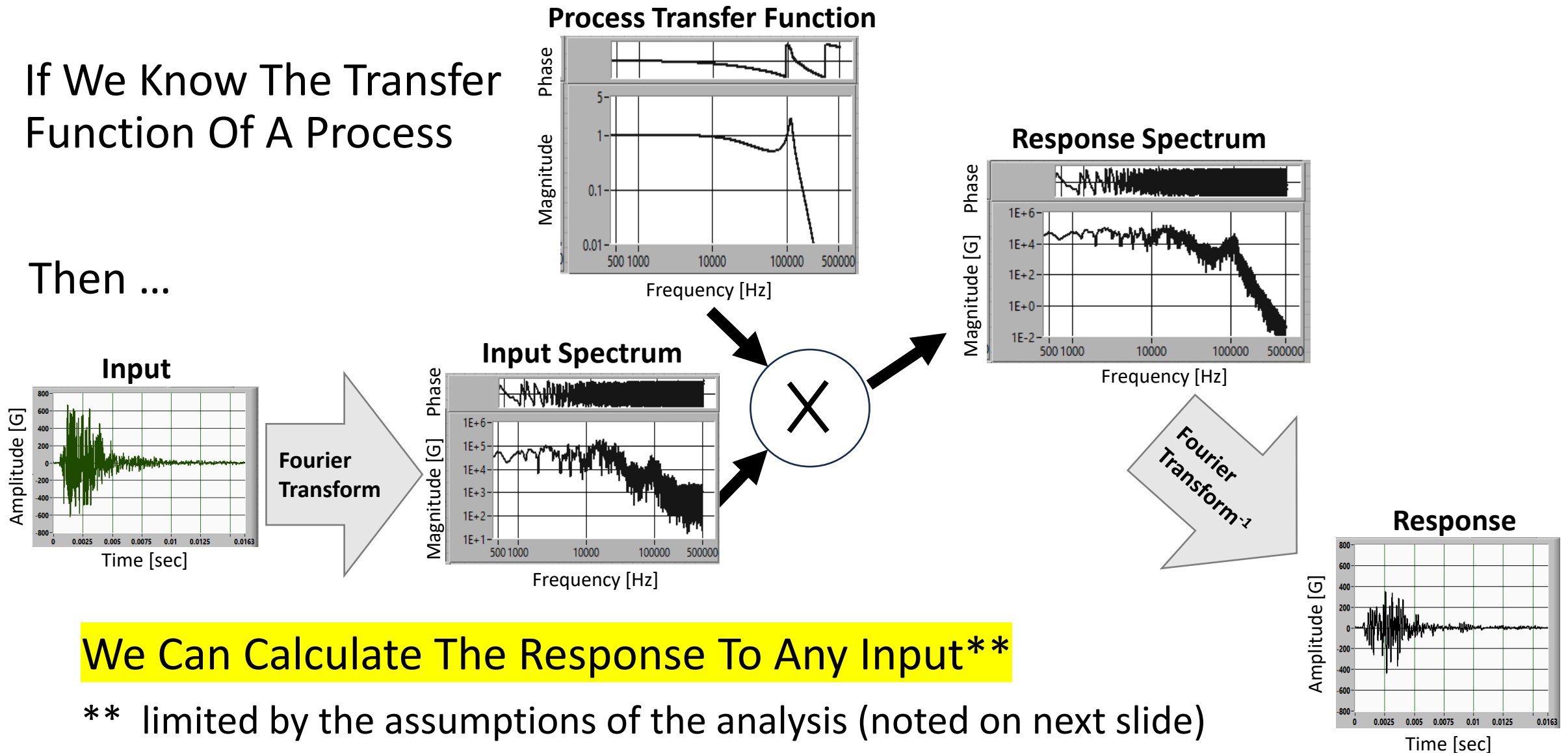


We Do Assume That The Elements Of Our Measurement System Are Linear!
(and a few other assumptions to be noted shortly)

A Small Manipulation-Inverting The Process

If We Know The Transfer Function Of A Process

Then ...



We Can Calculate The Response To Any Input**

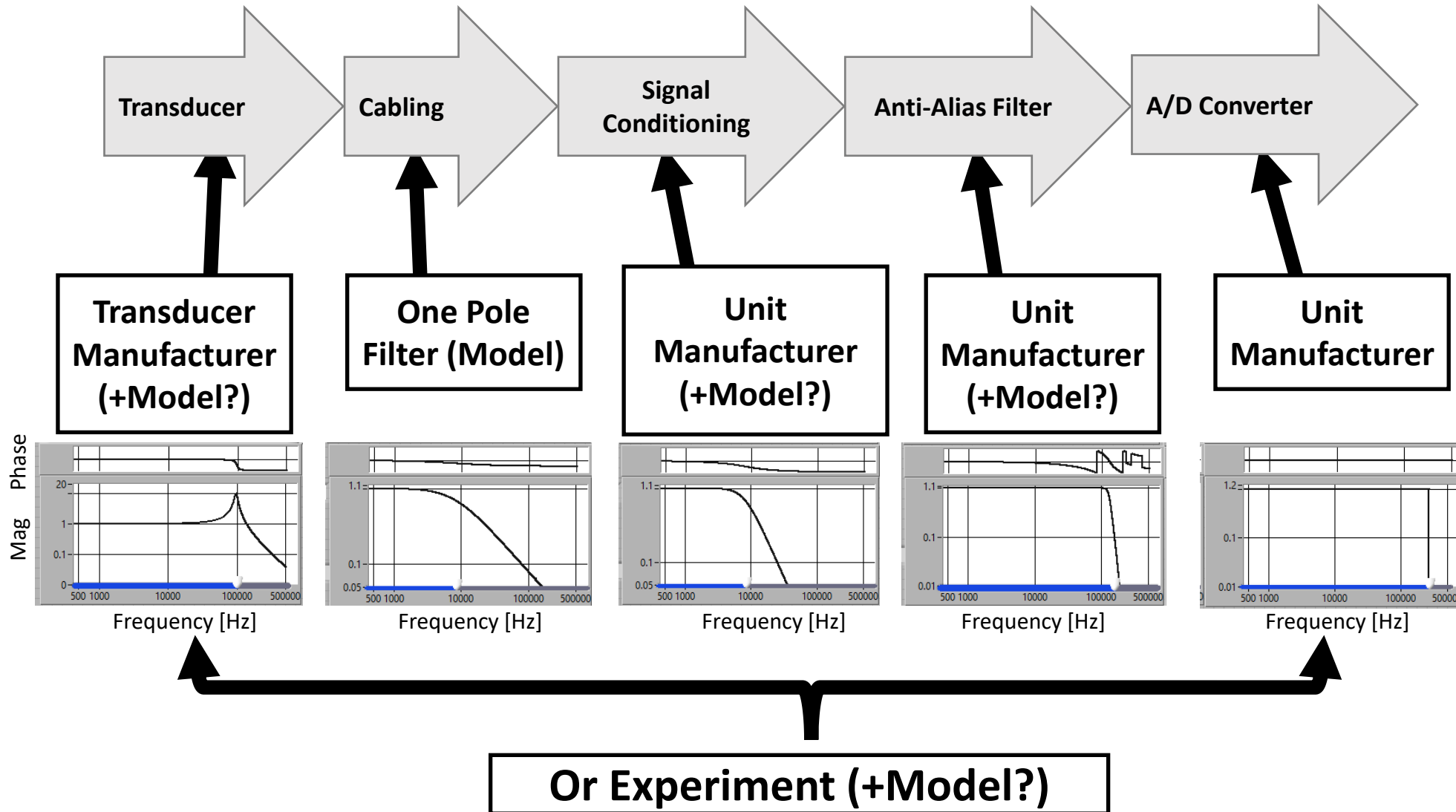
** limited by the assumptions of the analysis (noted on next slide)

Additional Calculation Details

- All components within the system respond linearly.
- Fourier Analysis imposes assumption of *Periodic Signals* in calcs.
 - Many transient shocks approximate this assumption.
- Calculations presented use the unscaled Fourier kernel only.
 - Plots shown are magnitude and phase of 1st half of the Fourier kernel coefficients (2nd half are just mirror of complex conjugate).
 - For Fourier inverse calculations, most software will require you to provide the full spectrum, including the 2nd half of the coefficients.
- For typical shock/impact data, signals are short, so each spectrum is computed in 1 block (there is no multi-block averaging and no windowing like done in vibration analysis).
- Calculations such as multiplication or division of spectra are computed with the underlying spectrum's complex coefficients (real + imaginary). The results of such math are complex coefficients too!

$$\Psi_k = \sum_{n=0}^{N-1} y_n e^{\left(-jk2\pi\frac{n}{N}\right)}$$

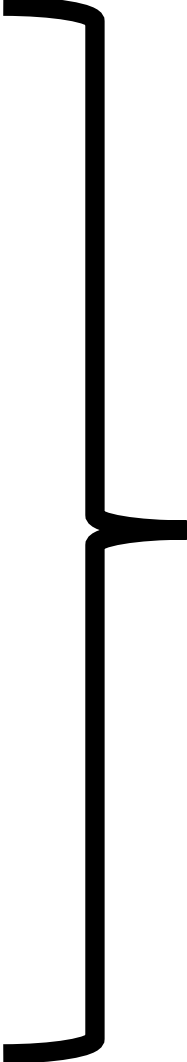
What Are The System Transfer Function Components?And, Where Do They Come From?



What Transfer Functions are Required.

.....And Where Do They Come From

- Transducer Transfer Function
 - Normally Provided By The Transducer Vendor, BUT typically not up to the resonant frequency!
- Cabling
 - Normally a One Pole Filter With Cutoff Controlled By the Cable Capacitance, The Transducer Output Impedance, and Cable Resistance.
- Signal Conditioning
 - Normally a One or Two-Pole Filter Described by the Manufacturer.
- Anti-Alias Filter
 - Characteristics From The Hardware Vendor
- A/D Converter
 - Characteristics From The Hardware Vendor



**OR
May Be These
Should Be
Characterized
Experimentally
???**

Special Calibration Provided By Transducer Vendor At Our Request

Endevco
PCB Piezotronics of NC, Inc.
10869 Highway 903
Halifax, NC 27839
USA
Tel: +1 (888) 684 0013
Fax: +1 (716) 685 3886
www.endevco.com

Calibration Certificate

Temperature (°C): 20 , (°F): 69
Relative Humidity (%): 48
Input Resistance (ohms): 564
Output Resistance (ohms): 572
ZMO (mV): -42.1
Resonance Frequency (Hz): 24851

Document number: 184747
Description: 4 Arm PR accelerometer
Manufacturer: ENDEVCO
Model Number: 7264C-2K-2-120
Serial Number: T29647

Transverse Sensitivity (%):

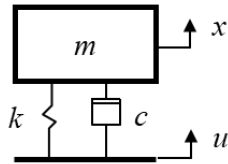
Excitation	Sensitivity	ZMO
5.0 V	0.0825 mV/g	20.8 mV
10.0 V	0.1765 mV/g	-42.1 mV

Sensitivity:

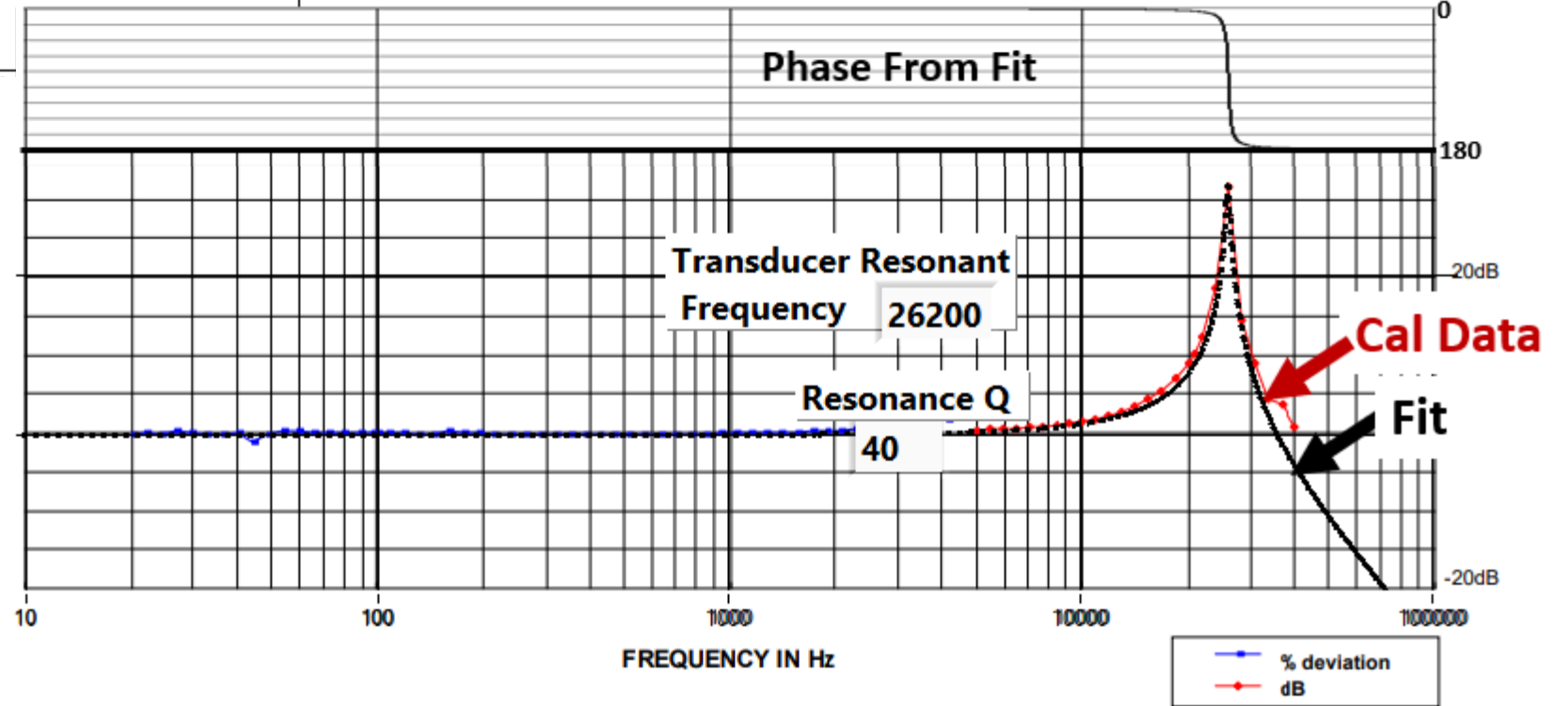
0.1765 mV/g @ 100 Hz, 10g pk
0.01800 mV/m/s² @ 100 Hz, 98 m/s² pk

Red Curve Is
Measurement By
Vendor.

Black Curves
(including Phase) Are
Fit by Us Using SDOF
Model



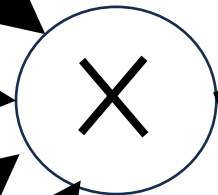
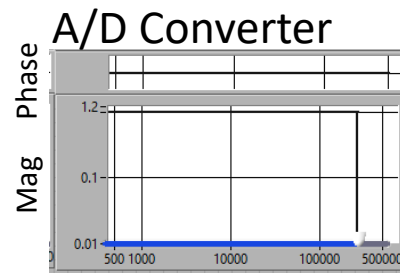
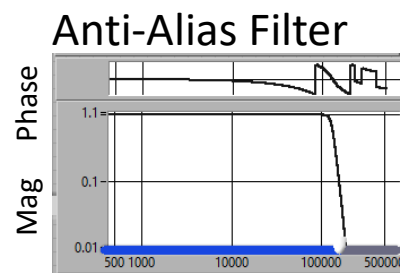
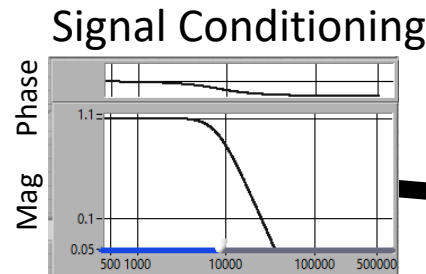
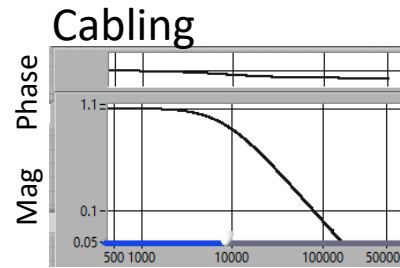
$$H(s) = \frac{2\zeta\omega_n s + \omega_n^2}{s^2 + 2\zeta\omega_n s + \omega_n^2}$$



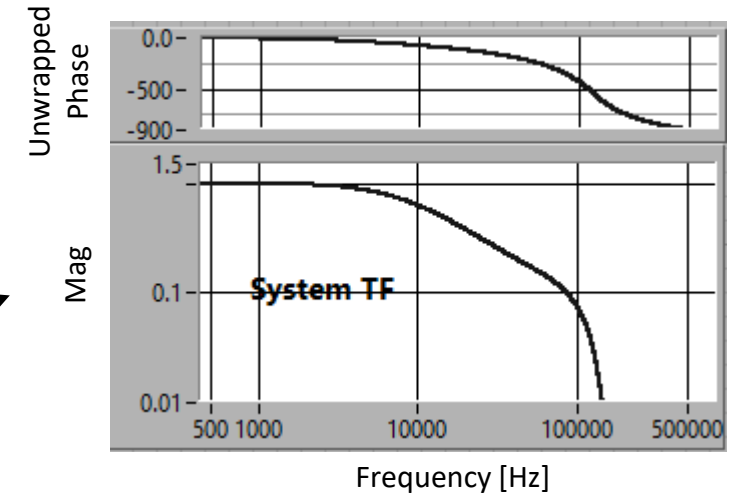
Analytically Modeling The Data System Transfer Function (Excluding the Transducer)

$$H(s) = \frac{1}{1 + s \cdot R \cdot C}$$

R, C are cable DC resistance and Cond-to-Cond capacitance



System Transfer Function (Both Phase & Magnitude)



$$H(z) = \frac{B_0 + B_1 z^{-1} + \dots + B_L z^{-L}}{1 + A_1 z^{-1} + \dots + A_L z^{-L}}$$

A & B values are filter coefficients

Notes:

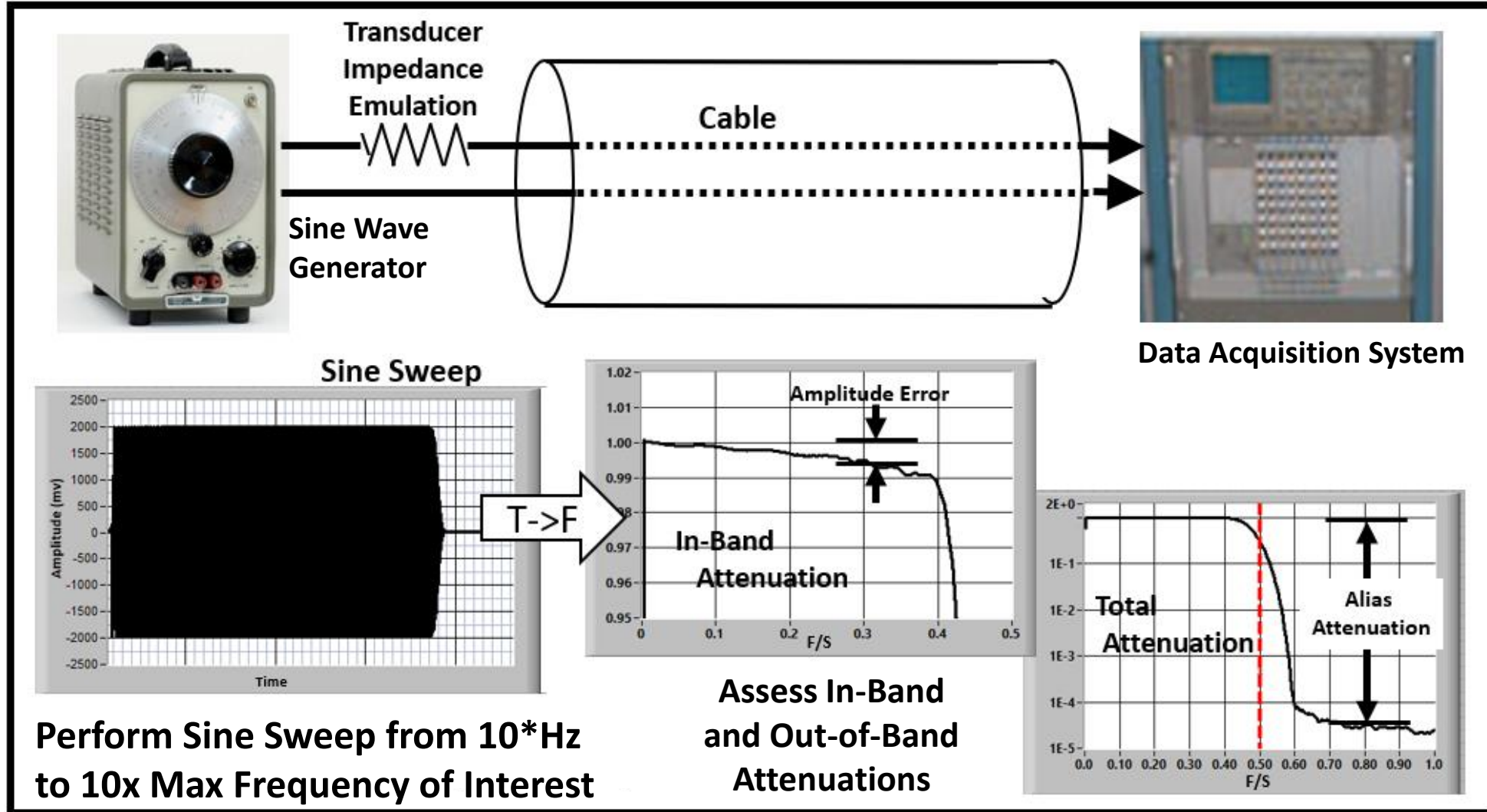
- The Transducer is NOT represented here but it could be included or kept separate.
- s is the Laplace domain, z is the digital domain
 - Ensure you understand which type of TF form you are using. You evaluate them differently.

$$s \rightarrow j \cdot 2 \cdot \pi \cdot f$$

$$z \rightarrow j \cdot 2 \cdot \pi \cdot f / f_s$$

Experimental Characterization Of The System Transfer Function (Excluding Transducer**)

** The electrical impedance of the transducer is included but not its full transfer function.

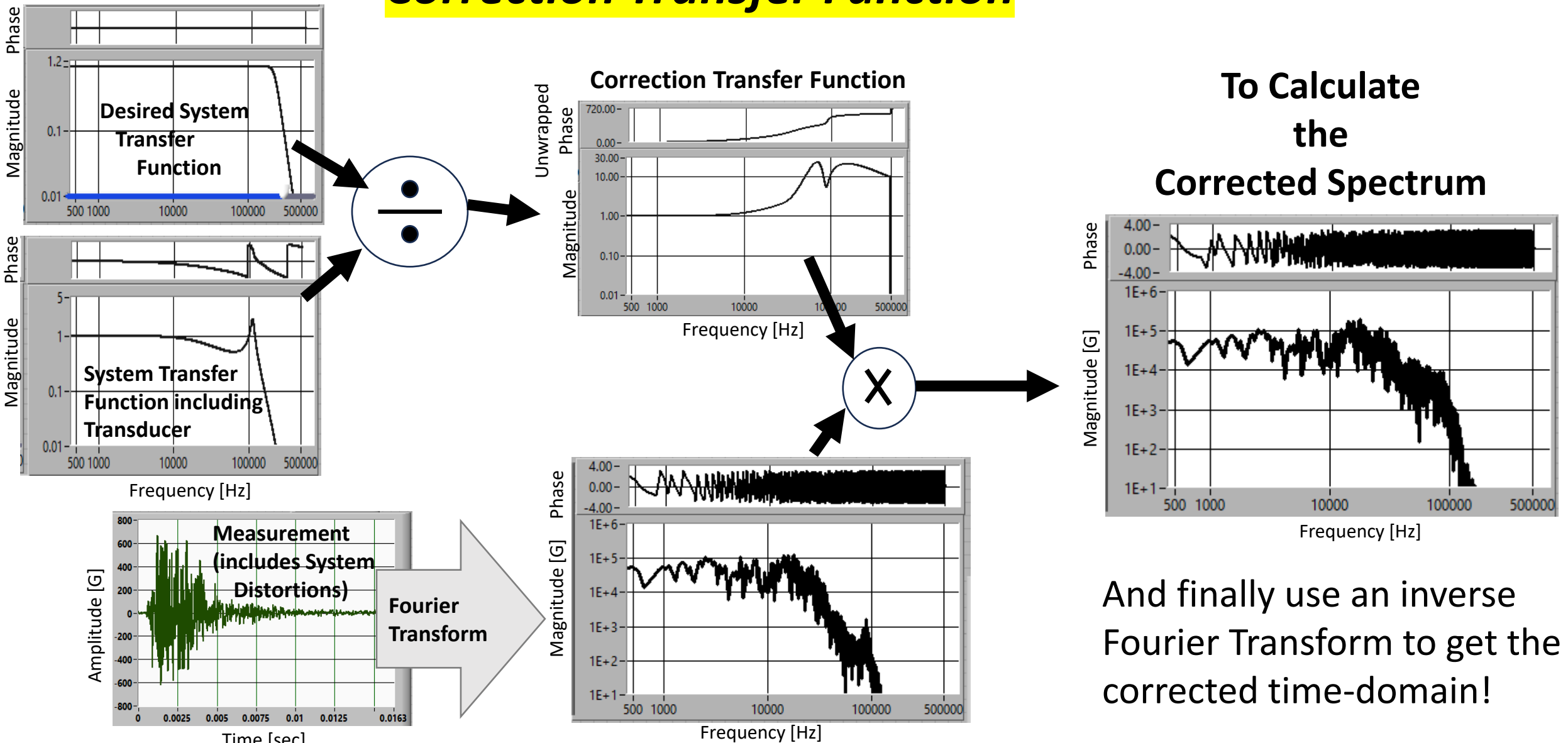


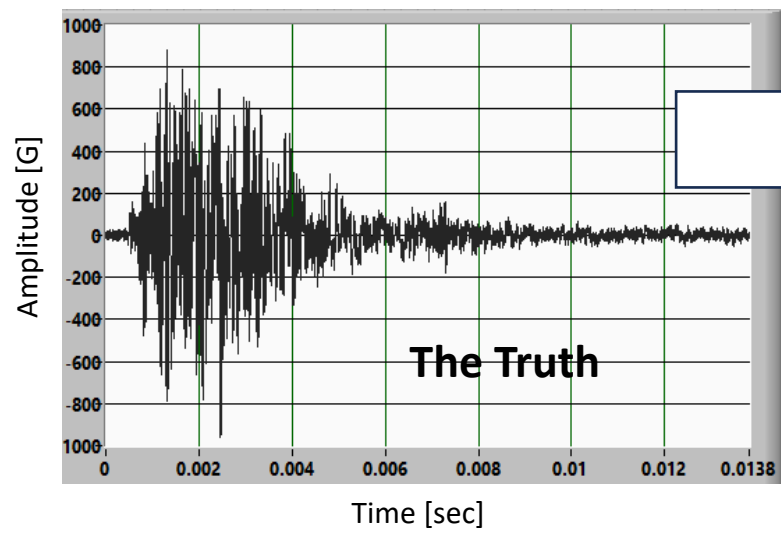
For a nice reference discussing this approach, see:

MEMS Shock Accelerometer Signal Modification Attributable To The Electrical Impedance Of Their Cables

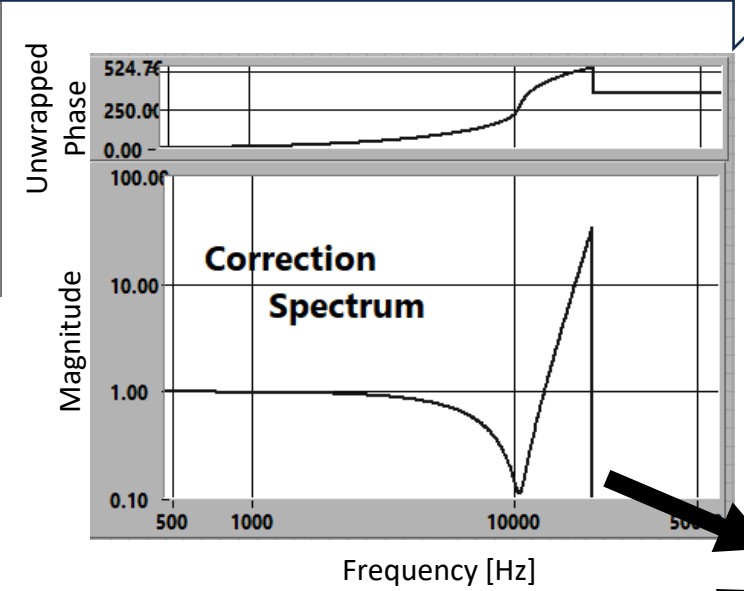
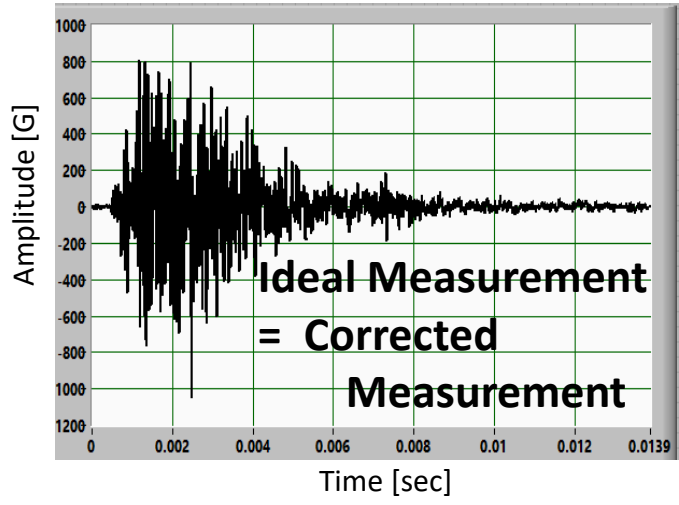
Patrick Walter, Alan Szary, James Woernley, 2021, Find at www.pcb.com

Then We Apply a Desired System Characteristic to Get a **Correction Transfer Function**

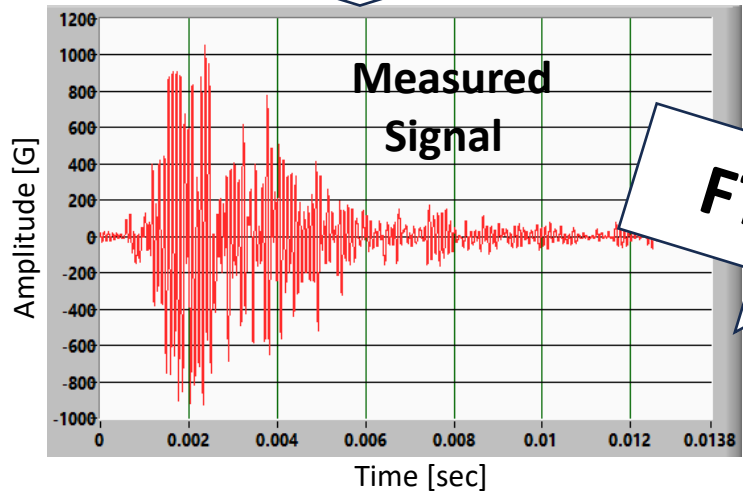




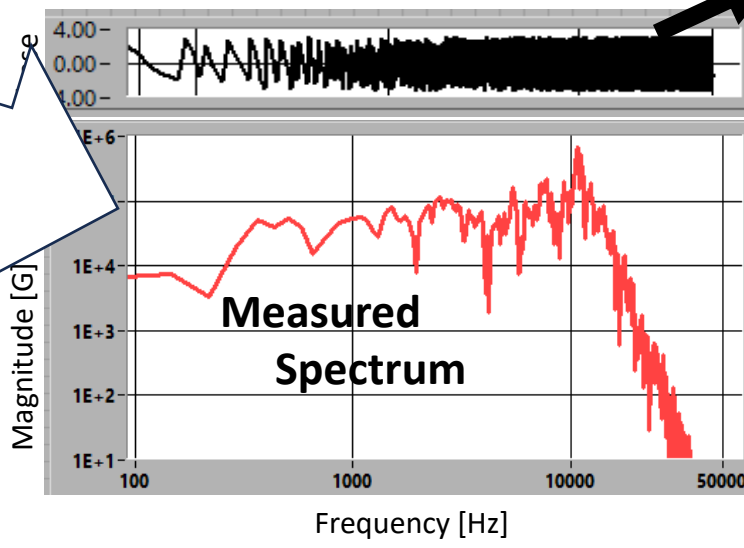
Ideal Desired Filter



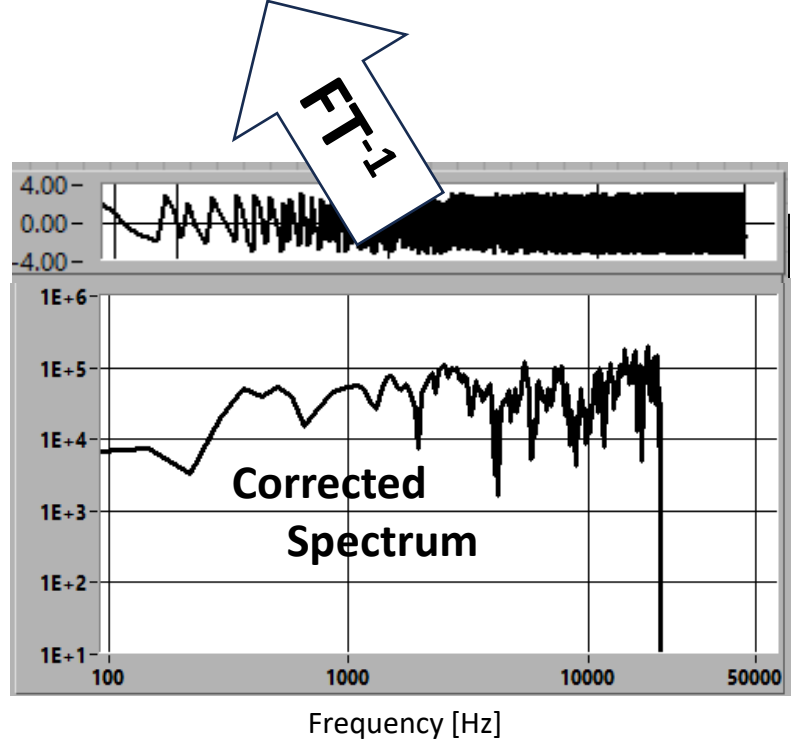
Measurement System



FT



X

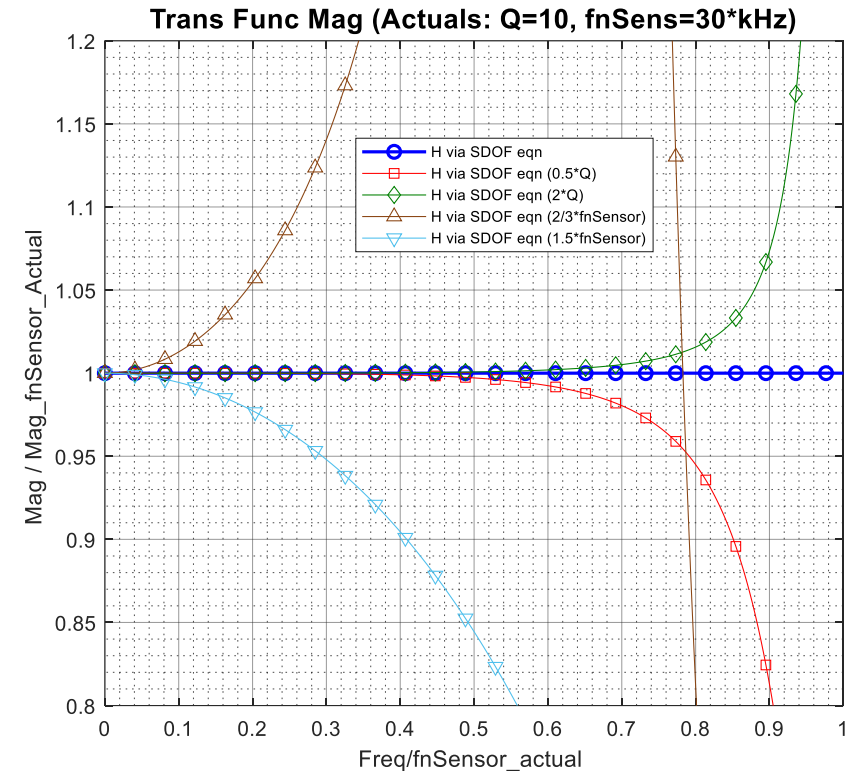


FT⁻¹

Limitations on Transfer Function Corrections

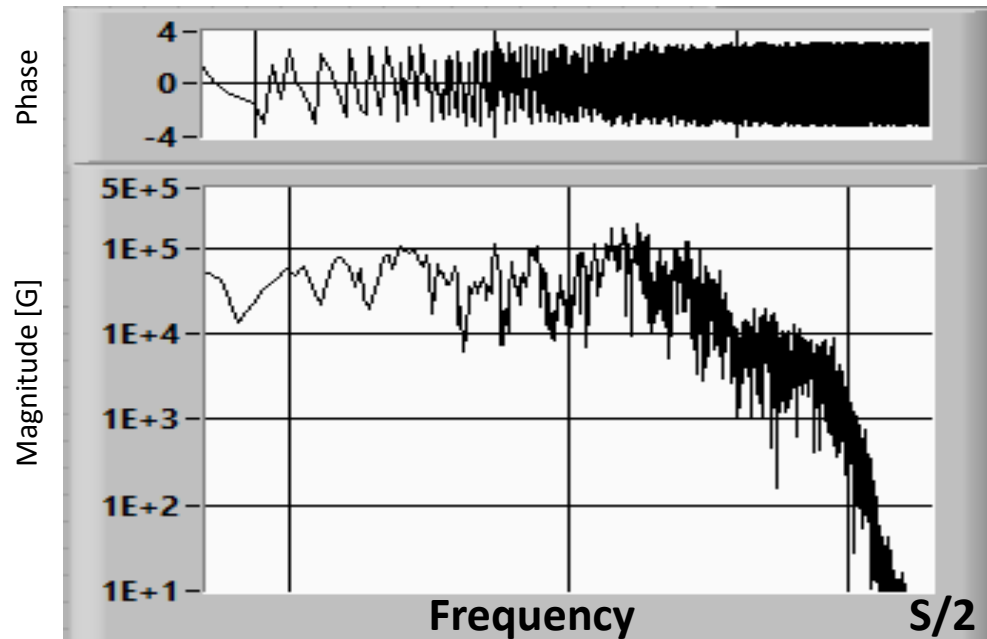
The following realities will limit how much of a correction you can make.

- Discrepancies between TF from analytical models compared to actual hardware. Additionally, uncertainty in parameters such as sensor resonance and sensor damping, or cabling capacitance and impedance.
- Numerical issues trying to revive frequency content squelched by low pass filtering in components of measurement chain.
 - Tip: Keeping flat pre-trigger data section in analysis helps judge when you are pushing correction to too high a frequency (you will see noise rise-up in the pre-trigger section).

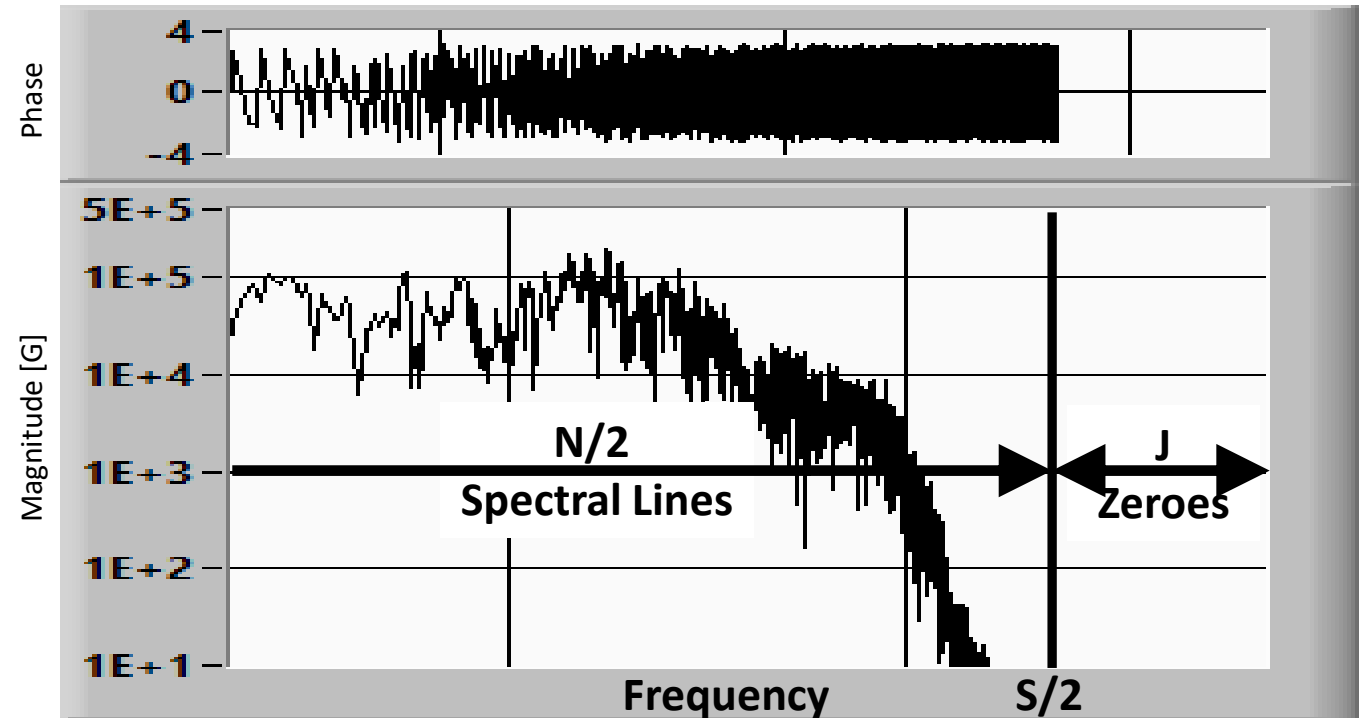


Above plot shows accuracy of TF correction for ideal accelerometer when f_n and Q of sensor have plausible uncertainties. TF most sensitive to f_n sensor, less sensitive Q of sensor.

We Can Upsample Via Spectrum Padding With Zeroes



Increasing the number of Spectral Lines by Padding Produces More Time History Points



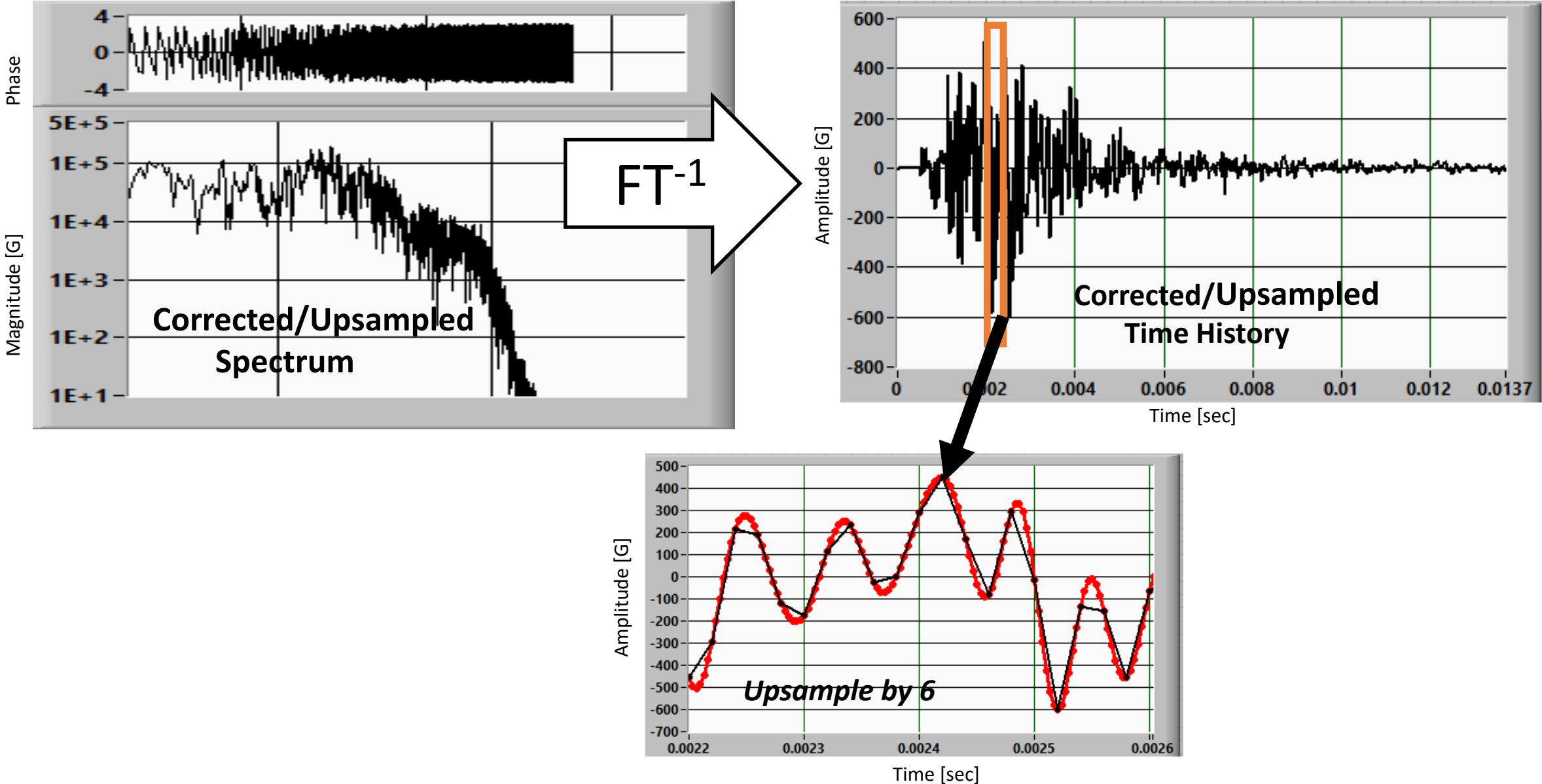
$$\text{Upsample Ratio} = (N/2 + J) / (N/2)$$

S=Sample Rate

N=Number of points in the Original Time History

J=Number of "Padding" Zeroes

Finally, We Convert back to the Time Domain



Conclusions

- All Measurement Systems Record A Distorted Version Of The Truth.
 - Various Components In The System Put In Different Types Of Distortions.
- Using Fourier Analysis, We Can Create Transfer Functions To Represent Various Components Of The System As Well As The Entire System.
 - Do This With Theoretical Models, Measurements, Or Some Combination.
- We Can Therefore Create A Correction Transform That Attempts To Nullify The Measurement's Distortions.
 - There Are Limitations To The Amount Of Correction That Can Be Made.
 - You Should Do Diligent Sanity Checking Of Any Such Corrections That Are Made.
- These Techniques Allows For Improved And More Consistent Results Comparisons From Different Laboratories/Experiments (Or Between Transient FEA Simulations And Physical Tests).

References

- 1. *Deconvolution as a Technique to Improve Measurement-System Data Integrity***
Patrick Walter, Experimental Mechanics August 1981
- 2. *Techniques For The Normalization OF Shock Data***
Strether Smith and William Hollowell,
62nd Shock and Vibration Symposium (October 1991)
- 3. *Frequency Response Compensation for Resonant Sensors***
Thomas P. Gerber, Douglas R. Firth, & Alan R. Szary
Precision Filters 2022
- 4. *MEMS Shock Accelerometer Signal Modification Attributable To The Electrical Impedance Of Their Cables***
Patrick Walter, Alan Szary, James Woernley 2021
Find at www.pcb.com